

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/936,624	LEAR ET AL.	
Examiner	Art Unit	
MARK A. MAIS	2419	

SEARCHED				
Class	Subclass	Date	Examiner	
370	254 255			
	351 352			
	389 390			
	396 398			
	395.31 400			
	406 408			
	422 428	2/26/2009	MAM	
709	220 221 223			
	224 225 226			
	227 228 229			
	231-235			
	238-242			
	244 249 203	2/26/2009	MAM	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCI		)
·	DATE	EXMR
See Inventorship Search/See Attached Electronic Search	5/2/2007	MAM
See Attached Electronic Search [updated]	11/30/2007	MAM
See Attached Electronic Search [updated]	3/4/2008	MAM
See Attached Electronic Search [updated]	9/22/2008	MAM
See Attached Electronic Search [updated]	2/26/2009	MAM